

SIMTEK6349

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of
Chihiro Araki

Patent No. 6,809,532
Issued: October 26, 2004
App. No.: 10/063,869
Filed: May 21, 2002
Conf. No.: 2434
Title: INSPECTION METHOD AND
INSPECTION APPARATUS FOR
SEMICONDUCTOR CIRCUIT
Examiner: T. Nguyen
Art Unit: 2829

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

STATUS LETTER

Dear Sir:

A request for a Certificate Of Correction was filed regarding this patent on February 28, 2005, but to date no action has been taken on this request even though it was filed over two years ago. Please advise when this will be acted upon.

Respectfully submitted:



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